

# PBSS4350SS

50 V, 2.7 A NPN/NPN low  $V_{CEsat}$  (BISS) transistor

Rev. 01 — 3 April 2007

Product data sheet

## 1. Product profile

### 1.1 General description

NPN/NPN double low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor in a medium power Surface-Mounted Device (SMD) plastic package.

Table 1. Product overview

| Type number | Package |      | NPN/PNP complement | PNP/PNP complement |
|-------------|---------|------|--------------------|--------------------|
|             | NXP     | Name |                    |                    |
| PBSS4350SS  | SOT96-1 | SO8  | PBSS4350SPN        | PBSS5350SS         |

### 1.2 Features

- Low collector-emitter saturation voltage  $V_{CEsat}$
- High collector current capability  $I_C$  and  $I_{CM}$
- High collector current gain ( $h_{FE}$ ) at high  $I_C$
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- Dual low power switches (e.g. motors, fans)
- Automotive

### 1.4 Quick reference data

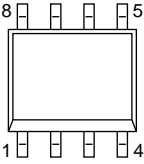
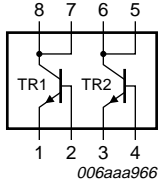
Table 2. Quick reference data

| Symbol                | Parameter                               | Conditions                       | Min   | Typ | Max | Unit       |
|-----------------------|---|----------------------------------|-------|-----|-----|------------|
| <b>Per transistor</b> |   |                                  |       |     |     |            |
| $V_{CEO}$             | collector-emitter voltage               | open base                        | -     | -   | 50  | V          |
| $I_C$                 | collector current                       |                                  | -     | -   | 2.7 | A          |
| $I_{CM}$              | peak collector current                  | single pulse;<br>$t_p \leq 1$ ms | -     | -   | 5   | A          |
| $R_{CEsat}$           | collector-emitter saturation resistance | $I_C = 2$ A;<br>$I_B = 200$ mA   | [1] - | 90  | 130 | m $\Omega$ |

[1] Pulse test:  $t_p \leq 300$   $\mu$ s;  $\delta \leq 0.02$ .

## 2. Pinning information

**Table 3. Pinning**

| Pin | Description   | Simplified outline  | Symbol  |
|-----|---------------|---|---|
| 1   | emitter TR1   |  |  |
| 2   | base TR1      |   |   |
| 3   | emitter TR2   |   |   |
| 4   | base TR2      |   |   |
| 5   | collector TR2 |   |   |
| 6   | collector TR2 |   |   |
| 7   | collector TR1 |   |   |
| 8   | collector TR1 |   |   |

## 3. Ordering information

**Table 4. Ordering information**

| Type number | Package |   | Version |
|-------------|---------|---|---------|
|             | Name    | Description   |         |
| PBSS4350SS  | SO8     | plastic small outline package; 8 leads; body width 3.9 mm | SOT96-1 |

## 4. Marking

**Table 5. Marking codes**

| Type number | Marking code |
|-------------|--------------|
| PBSS4350SS  | 4350SS       |

## 5. Limiting values

**Table 6. Limiting values**

*In accordance with the Absolute Maximum Rating System (IEC 60134).*

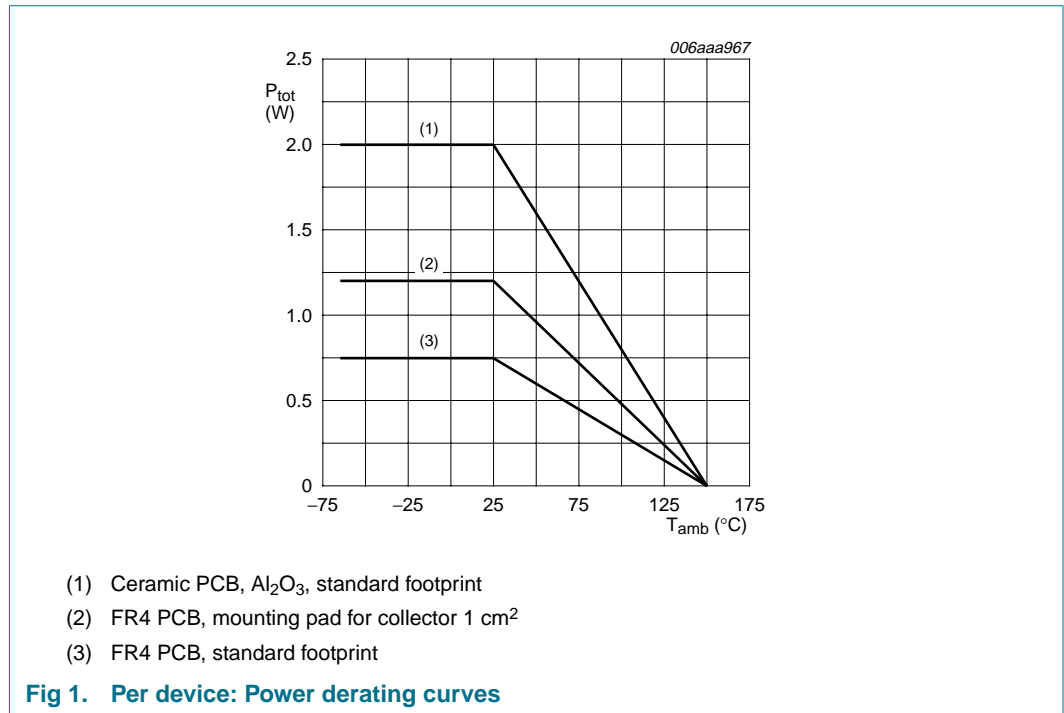
| Symbol                | Parameter                 | Conditions                       | Min | Max | Unit |   |
|-----------------------|---------------------------|----------------------------------|-----|-----|------|---|
| <b>Per transistor</b> |                           |                                  |     |     |      |   |
| $V_{CBO}$             | collector-base voltage    | open emitter                     | -   | 50  | V    |   |
| $V_{CEO}$             | collector-emitter voltage | open base                        | -   | 50  | V    |   |
| $V_{EBO}$             | emitter-base voltage      | open collector                   | -   | 5   | V    |   |
| $I_C$                 | collector current         |                                  | -   | 2.7 | A    |   |
| $I_{CM}$              | peak collector current    | single pulse;<br>$t_p \leq 1$ ms | -   | 5   | A    |   |
| $I_B$                 | base current              |                                  | -   | 0.5 | A    |   |
| $P_{tot}$             | total power dissipation   | $T_{amb} \leq 25$ °C             | [1] | -   | 0.55 | W |
|                       |                           |                                  | [2] | -   | 0.87 | W |
|                       |                           |                                  | [3] | -   | 1.43 | W |

**Table 6. Limiting values ...continued**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol            | Parameter               | Conditions                  | Min | Max  | Unit |   |
|-------------------|-------------------------|-----------------------------|-----|------|------|---|
| <b>Per device</b> |                         |                             |     |      |      |   |
| $P_{tot}$         | total power dissipation | $T_{amb} \leq 25\text{ °C}$ | [1] | -    | 0.75 | W |
|                   |                         |                             | [2] | -    | 1.2  | W |
|                   |                         |                             | [3] | -    | 2    | W |
| $T_j$             | junction temperature    |                             | -   | 150  | °C   |   |
| $T_{amb}$         | ambient temperature     |                             | -65 | +150 | °C   |   |
| $T_{stg}$         | storage temperature     |                             | -65 | +150 | °C   |   |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

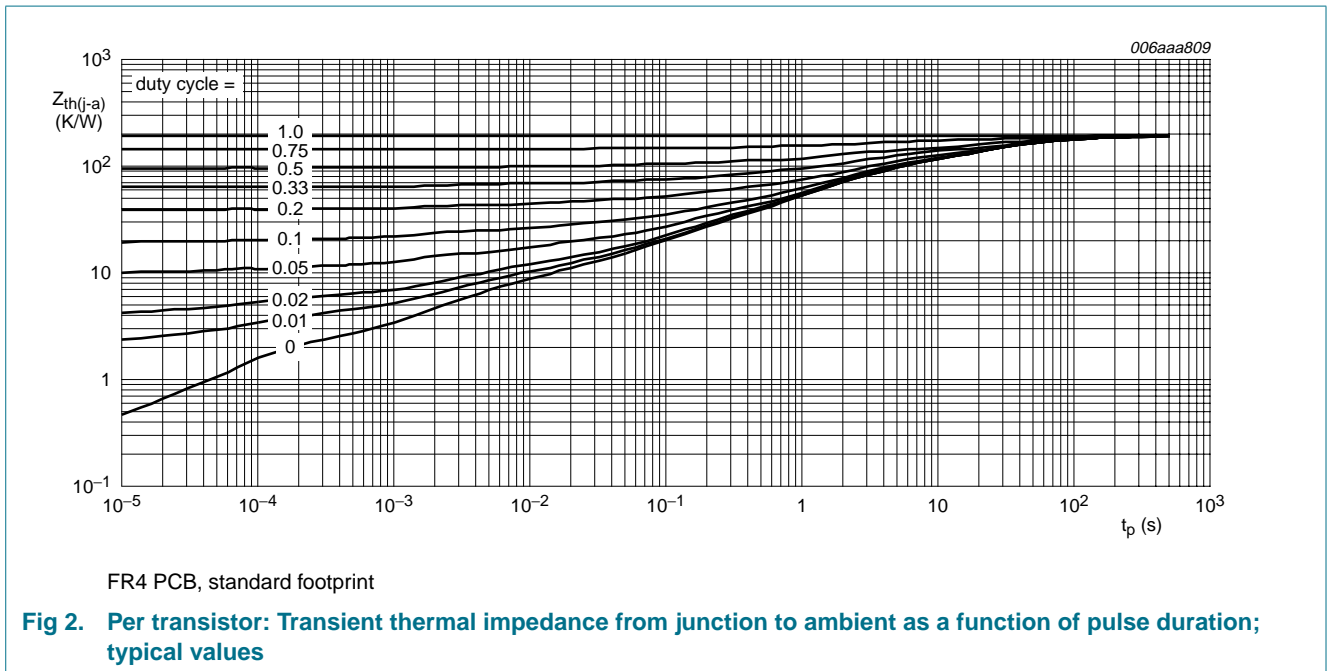


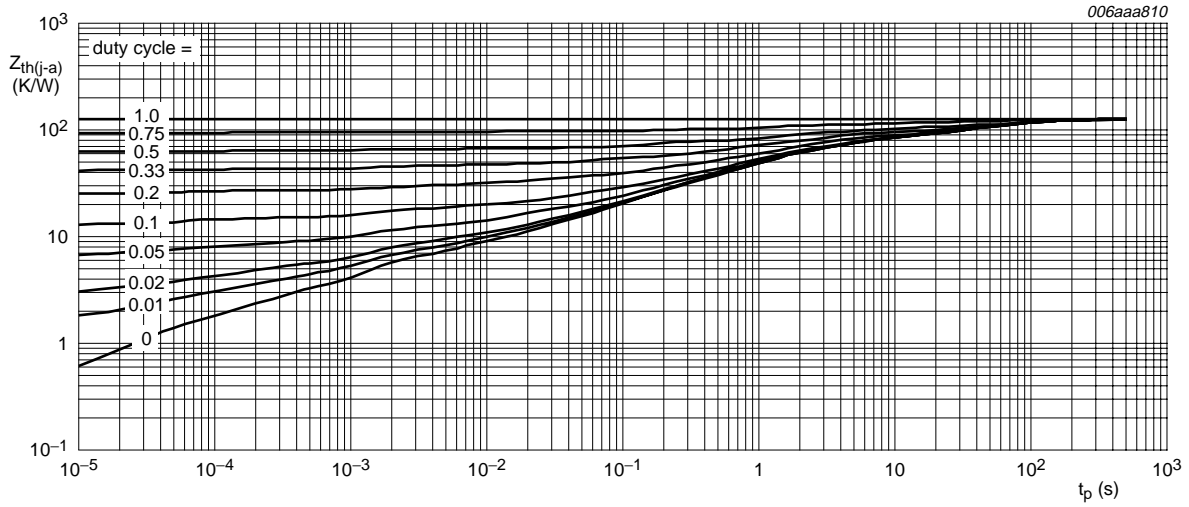
## 6. Thermal characteristics

**Table 7. Thermal characteristics**

| Symbol                | Parameter  | Conditions  | Min | Typ | Max | Unit |     |
|-----------------------|--|-------------|-----|-----|-----|------|-----|
| <b>Per transistor</b> |  |             |     |     |     |      |     |
| $R_{th(j-a)}$         | thermal resistance from junction to ambient      | in free air | [1] | -   | -   | 227  | K/W |
|                       |  |             | [2] | -   | -   | 144  | K/W |
|                       |  |             | [3] | -   | -   | 87   | K/W |
| $R_{th(j-sp)}$        | thermal resistance from junction to solder point |             | -   | -   | 40  | K/W  |     |
| <b>Per device</b>     |  |             |     |     |     |      |     |
| $R_{th(j-a)}$         | thermal resistance from junction to ambient      | in free air | [1] | -   | -   | 167  | K/W |
|                       |  |             | [2] | -   | -   | 104  | K/W |
|                       |  |             | [3] | -   | -   | 63   | K/W |

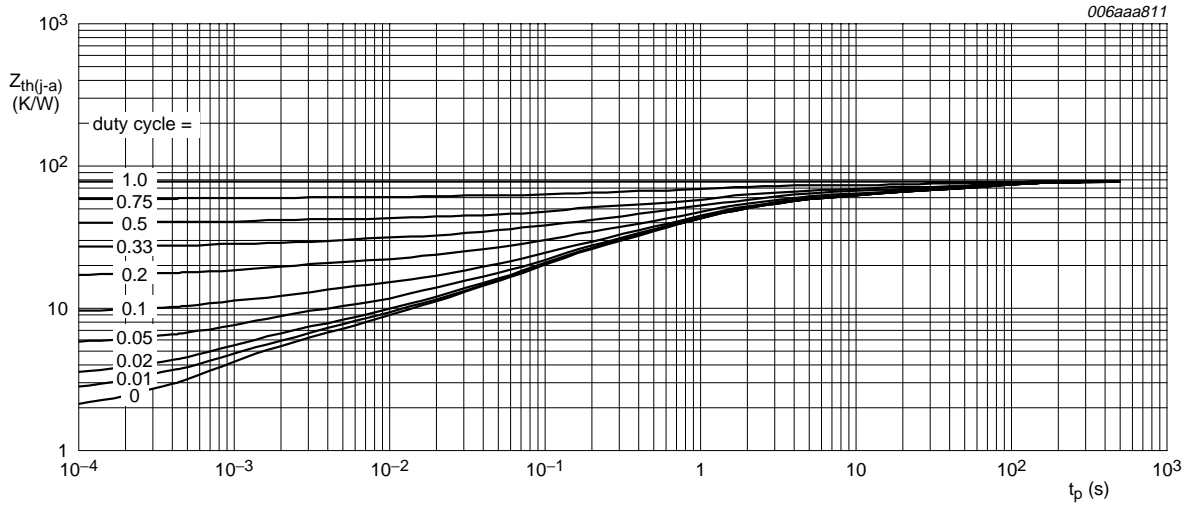
- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.





FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>

**Fig 3. Per transistor: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint

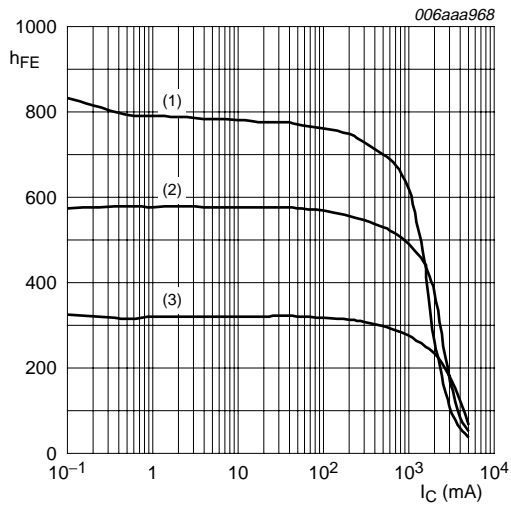
**Fig 4. Per transistor: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**

## 7. Characteristics

**Table 8. Characteristics**
 $T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified.

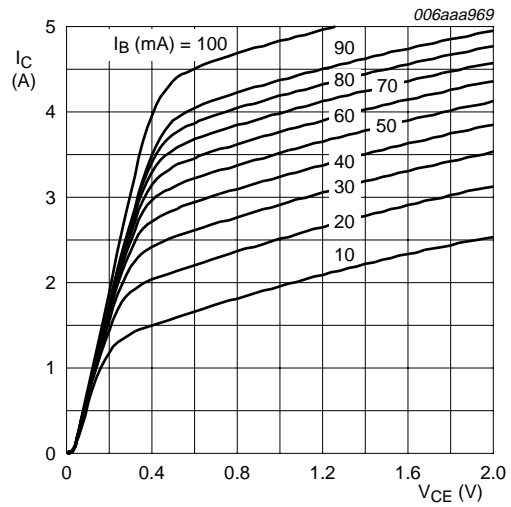
| Symbol                | Parameter                               | Conditions   | Min | Typ  | Max | Unit          |                  |
|-----------------------|---|--|-----|------|-----|---------------|------------------|
| <b>Per transistor</b> |   |  |     |      |     |               |                  |
| $I_{CBO}$             | collector-base cut-off current          | $V_{CB} = 50\text{ V}; I_E = 0\text{ A}$   | -   | -    | 100 | nA            |                  |
|                       |   | $V_{CB} = 50\text{ V}; I_E = 0\text{ A}; T_j = 150\text{ }^{\circ}\text{C}$                  | -   | -    | 50  | $\mu\text{A}$ |                  |
| $I_{CES}$             | collector-emitter cut-off current       | $V_{CE} = 50\text{ V}; V_{BE} = 0\text{ V}$  | -   | -    | 100 | nA            |                  |
| $I_{EBO}$             | emitter-base cut-off current            | $V_{EB} = 5\text{ V}; I_C = 0\text{ A}$  | -   | -    | 100 | nA            |                  |
| $h_{FE}$              | DC current gain                         | $V_{CE} = 2\text{ V}; I_C = 100\text{ mA}$   | 300 | 520  | -   |               |                  |
|                       |   | $V_{CE} = 2\text{ V}; I_C = 500\text{ mA}$   | [1] | 300  | 500 | -             |                  |
|                       |   | $V_{CE} = 2\text{ V}; I_C = 1\text{ A}$  | [1] | 300  | 470 | -             |                  |
|                       |   | $V_{CE} = 2\text{ V}; I_C = 2\text{ A}$  | [1] | 200  | 340 | -             |                  |
|                       |   | $V_{CE} = 2\text{ V}; I_C = 2.7\text{ A}$  | [1] | 120  | 180 | -             |                  |
| $V_{CEsat}$           | collector-emitter saturation voltage    |  | [1] |      |     |               |                  |
|                       |   | $I_C = 0.5\text{ A}; I_B = 50\text{ mA}$   | -   | 50   | 80  | mV            |                  |
|                       |   | $I_C = 1\text{ A}; I_B = 50\text{ mA}$   | -   | 100  | 160 | mV            |                  |
|                       |   | $I_C = 2\text{ A}; I_B = 100\text{ mA}$  | -   | 190  | 280 | mV            |                  |
|                       |   | $I_C = 2\text{ A}; I_B = 200\text{ mA}$  | -   | 180  | 260 | mV            |                  |
|                       |   | $I_C = 2.7\text{ A}; I_B = 270\text{ mA}$  | -   | 240  | 340 | mV            |                  |
| $R_{CEsat}$           | collector-emitter saturation resistance | $I_C = 2\text{ A}; I_B = 200\text{ mA}$  | [1] | -    | 90  | 130           | $\text{m}\Omega$ |
|                       |   |  | [1] |      |     |               |                  |
| $V_{BEsat}$           | base-emitter saturation voltage         |  | [1] |      |     |               |                  |
|                       |   | $I_C = 2\text{ A}; I_B = 100\text{ mA}$  | -   | 0.95 | 1.1 | V             |                  |
|                       |   | $I_C = 2.7\text{ A}; I_B = 270\text{ mA}$  | -   | 1.1  | 1.2 | V             |                  |
| $V_{BEon}$            | base-emitter turn-on voltage            | $V_{CE} = 2\text{ V}; I_C = 1\text{ A}$  | [1] | -    | 0.8 | 1.2           | V                |
| $t_d$                 | delay time                              | $V_{CC} = 10\text{ V}; I_C = 2\text{ A}; I_{Bon} = 100\text{ mA}; I_{Boff} = -100\text{ mA}$ | -   | 8    | -   | ns            |                  |
| $t_r$                 | rise time                               |  | -   | 96   | -   | ns            |                  |
| $t_{on}$              | turn-on time                            |  | -   | 104  | -   | ns            |                  |
| $t_s$                 | storage time                            |  | -   | 355  | -   | ns            |                  |
| $t_f$                 | fall time                               |  | -   | 165  | -   | ns            |                  |
| $t_{off}$             | turn-off time                           |  | -   | 520  | -   | ns            |                  |
| $C_c$                 | collector capacitance                   | $V_{CB} = 10\text{ V}; I_E = i_e = 0\text{ A}; f = 1\text{ MHz}$                             | -   | 18   | 25  | pF            |                  |

[1] Pulse test:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0.02$ .



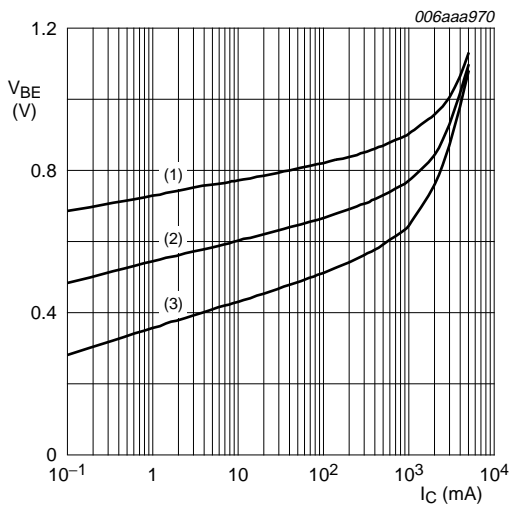
$V_{CE} = 2\text{ V}$   
 (1)  $T_{amb} = 100\text{ }^\circ\text{C}$   
 (2)  $T_{amb} = 25\text{ }^\circ\text{C}$   
 (3)  $T_{amb} = -55\text{ }^\circ\text{C}$

**Fig 5. DC current gain as a function of collector current; typical values**



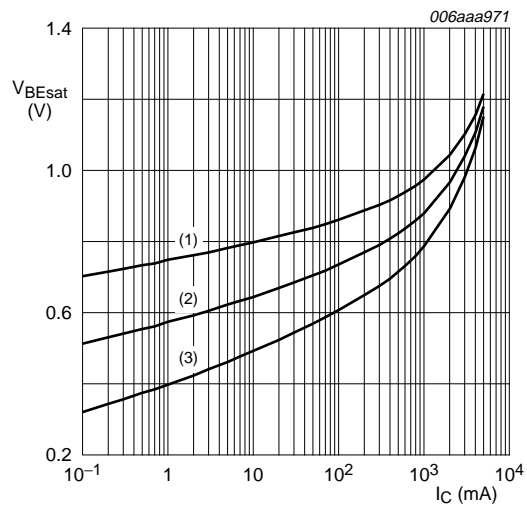
$T_{amb} = 25\text{ }^\circ\text{C}$

**Fig 6. Collector current as a function of collector-emitter voltage; typical values**



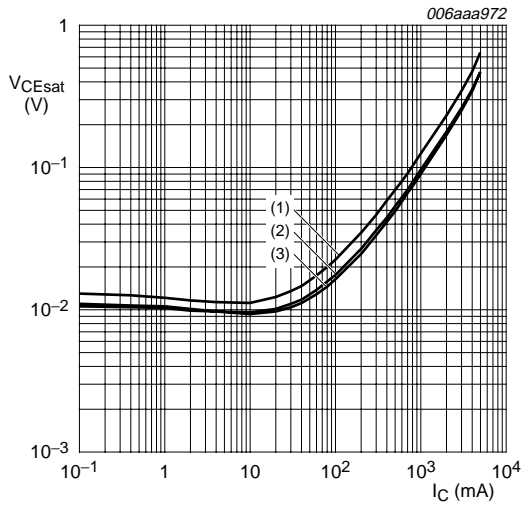
$V_{CE} = 2\text{ V}$   
 (1)  $T_{amb} = -55\text{ }^\circ\text{C}$   
 (2)  $T_{amb} = 25\text{ }^\circ\text{C}$   
 (3)  $T_{amb} = 100\text{ }^\circ\text{C}$

**Fig 7. Base-emitter voltage as a function of collector current; typical values**



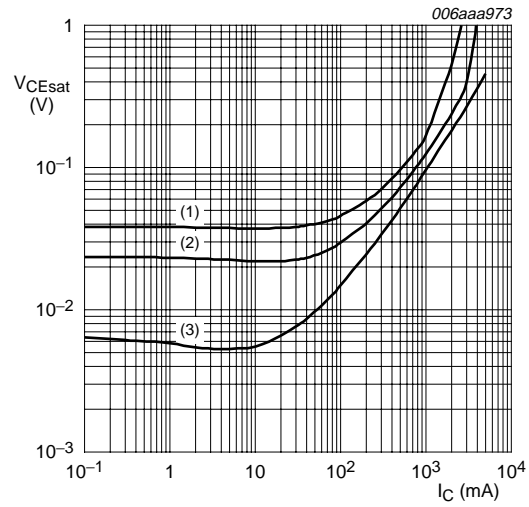
$I_C/I_B = 20$   
 (1)  $T_{amb} = -55\text{ }^\circ\text{C}$   
 (2)  $T_{amb} = 25\text{ }^\circ\text{C}$   
 (3)  $T_{amb} = 100\text{ }^\circ\text{C}$

**Fig 8. Base-emitter saturation voltage as a function of collector current; typical values**



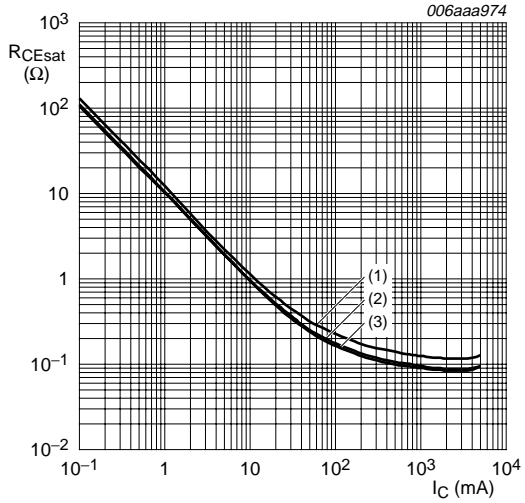
$I_C/I_B = 20$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values**



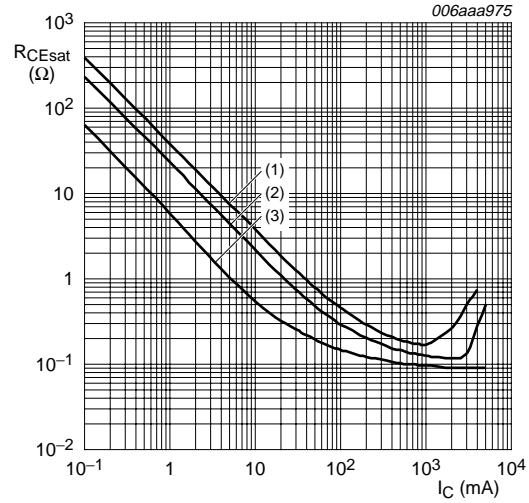
$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 100$   
 (2)  $I_C/I_B = 50$   
 (3)  $I_C/I_B = 10$

**Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values**



$I_C/I_B = 20$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values**

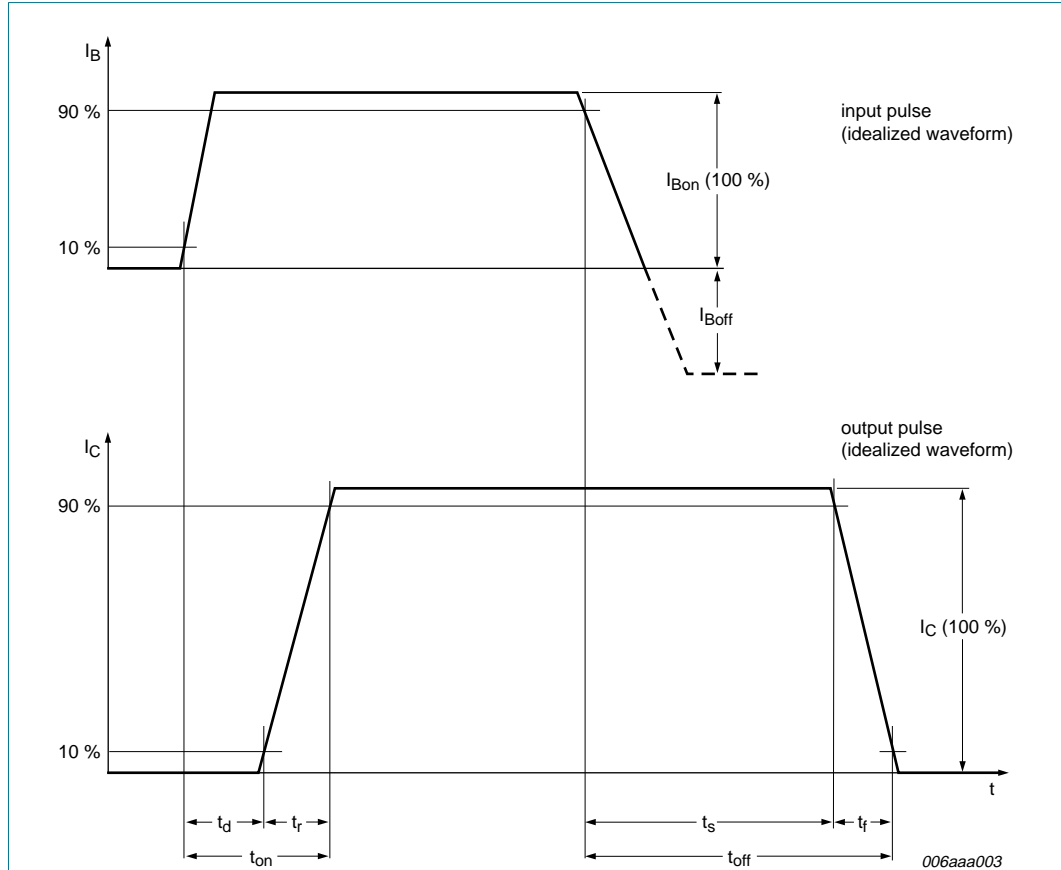


$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 100$   
 (2)  $I_C/I_B = 50$   
 (3)  $I_C/I_B = 10$

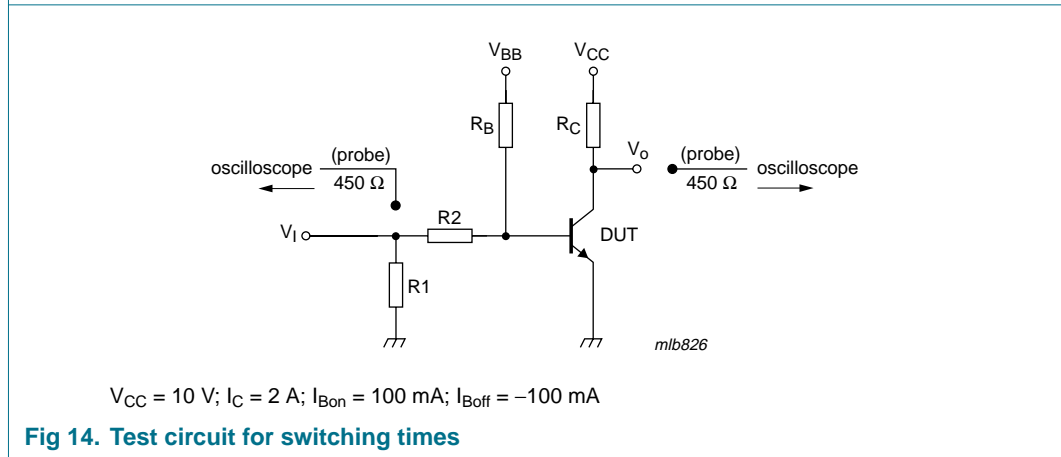
**Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values**



**8. Test information**

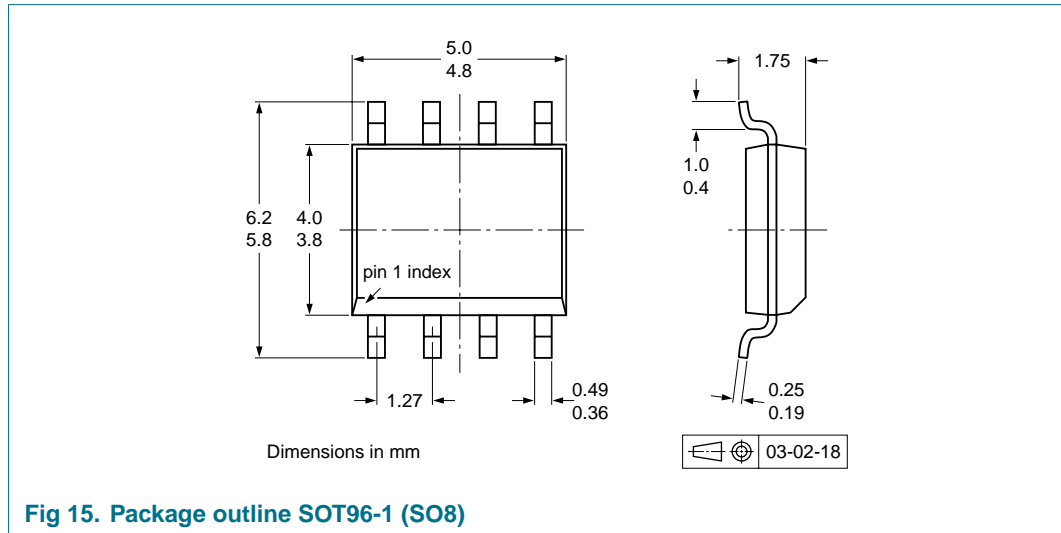


**Fig 13. BISS transistor switching time definition**



**Fig 14. Test circuit for switching times**

## 9. Package outline



## 10. Packing information

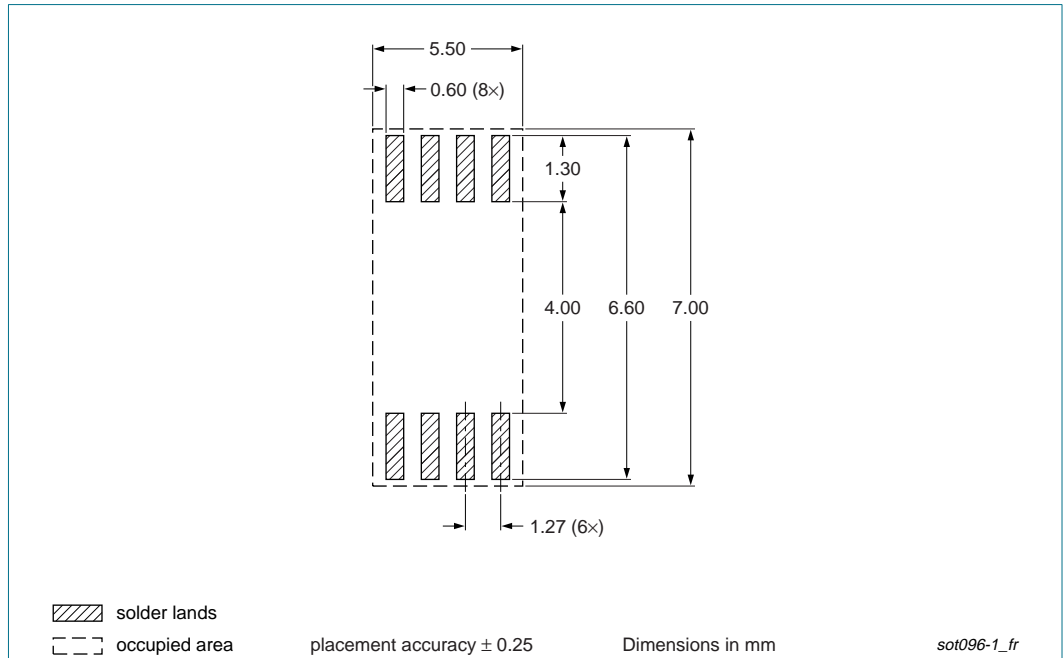
**Table 9. Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.<sup>[1]</sup>

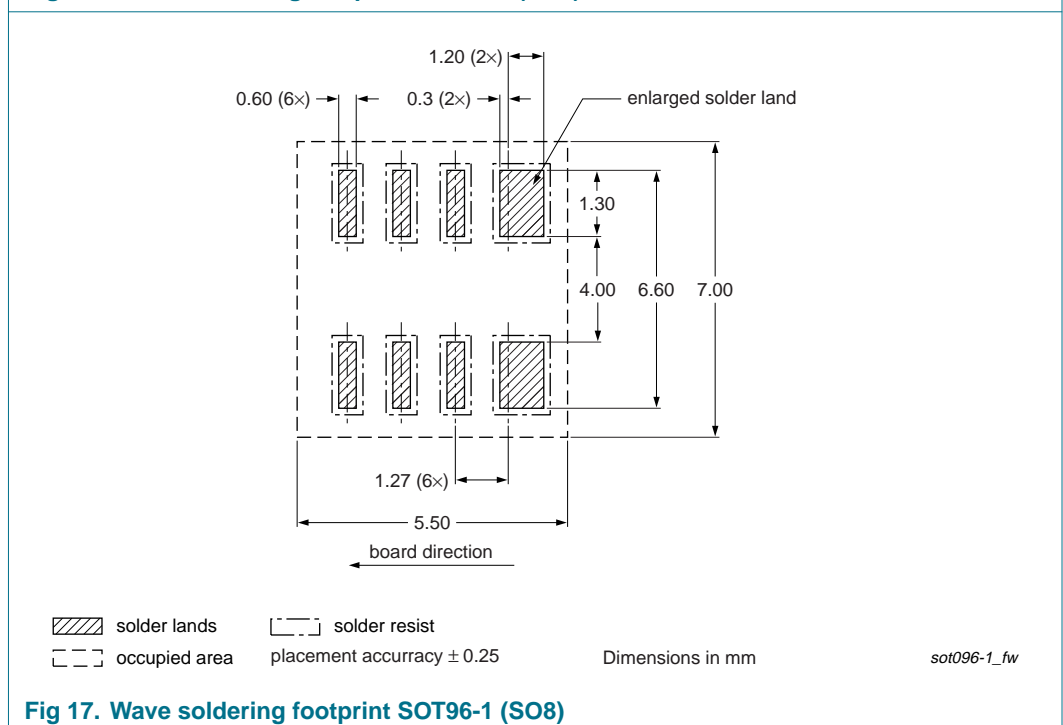
| Type number | Package | Description                     | Packing quantity |      |
|-------------|---------|---------------------------------|------------------|------|
|             |         |                                 | 1000             | 2500 |
| PBSS4350SS  | SOT96-1 | 8 mm pitch, 12 mm tape and reel | -115             | -118 |

[1] For further information and the availability of packing methods, see [Section 14](#).

## 11. Soldering



**Fig 16. Reflow soldering footprint SOT96-1 (SO8)**



**Fig 17. Wave soldering footprint SOT96-1 (SO8)**

## 12. Revision history

**Table 10. Revision history**

| Document ID  | Release date | Data sheet status  | Change notice | Supersedes |
|--------------|--------------|--------------------|---------------|------------|
| PBSS4350SS_1 | 20070403     | Product data sheet | -             | -          |

## 13. Legal information

### 13.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition  |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
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| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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